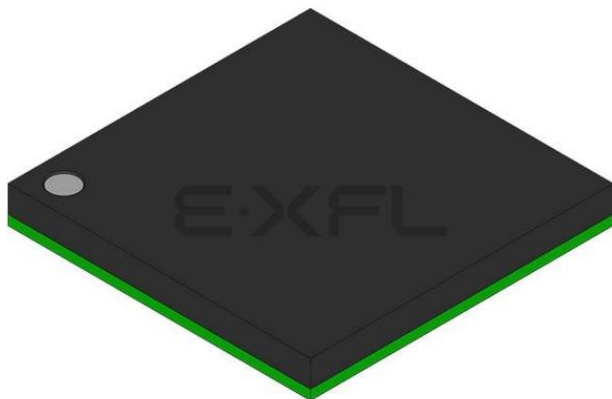




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### Understanding [Embedded - CPLDs \(Complex Programmable Logic Devices\)](#)

Embedded - CPLDs, or Complex Programmable Logic Devices, are highly versatile digital logic devices used in electronic systems. These programmable components are designed to perform complex logical operations and can be customized for specific applications. Unlike fixed-function ICs, CPLDs offer the flexibility to reprogram their configuration, making them an ideal choice for various embedded systems. They consist of a set of logic gates and programmable interconnects, allowing designers to implement complex logic circuits without needing custom hardware.

### Applications of Embedded - CPLDs

#### Details

|                                 |                                                                                                                                               |
|---------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------|
| Product Status                  | Active                                                                                                                                        |
| Programmable Type               | In System Programmable                                                                                                                        |
| Delay Time tpd(1) Max           | 9 ns                                                                                                                                          |
| Voltage Supply - Internal       | 1.71V ~ 1.89V                                                                                                                                 |
| Number of Logic Elements/Blocks | 570                                                                                                                                           |
| Number of Macrocells            | 440                                                                                                                                           |
| Number of Gates                 | -                                                                                                                                             |
| Number of I/O                   | 76                                                                                                                                            |
| Operating Temperature           | 0°C ~ 85°C (TJ)                                                                                                                               |
| Mounting Type                   | Surface Mount                                                                                                                                 |
| Package / Case                  | 100-TFBGA                                                                                                                                     |
| Supplier Device Package         | 100-MBGA (6x6)                                                                                                                                |
| Purchase URL                    | <a href="https://www.e-xfl.com/pro/item?MUrl=&amp;PartUrl=epm570zm100c6n">https://www.e-xfl.com/pro/item?MUrl=&amp;PartUrl=epm570zm100c6n</a> |

MAX II devices are available in space-saving FineLine BGA, Micro FineLine BGA, and thin quad flat pack (TQFP) packages (refer to Table 1–3 and Table 1–4). MAX II devices support vertical migration within the same package (for example, you can migrate between the EPM570, EPM1270, and EPM2210 devices in the 256-pin FineLine BGA package). Vertical migration means that you can migrate to devices whose dedicated pins and JTAG pins are the same and power pins are subsets or supersets for a given package across device densities. The largest density in any package has the highest number of power pins; you must lay out for the largest planned density in a package to provide the necessary power pins for migration. For I/O pin migration across densities, cross reference the available I/O pins using the device pin-outs for all planned densities of a given package type to identify which I/O pins can be migrated. The Quartus® II software can automatically cross-reference and place all pins for you when given a device migration list.

**Table 1–3.** MAX II Packages and User I/O Pins

| Device              | 68-Pin<br>Micro<br>FineLine<br>BGA (1) | 100-Pin<br>Micro<br>FineLine<br>BGA (1) | 100-Pin<br>FineLine<br>BGA | 100-Pin<br>TQFP | 144-Pin<br>TQFP | 144-Pin<br>Micro<br>FineLine<br>BGA (1) | 256-Pin<br>Micro<br>FineLine<br>BGA (1) | 256-Pin<br>FineLine<br>BGA | 324-Pin<br>FineLine<br>BGA |
|---------------------|----------------------------------------|-----------------------------------------|----------------------------|-----------------|-----------------|-----------------------------------------|-----------------------------------------|----------------------------|----------------------------|
| EPM240<br>EPM240G   | —                                      | 80                                      | 80                         | 80              | —               | —                                       | —                                       | —                          | —                          |
| EPM570<br>EPM570G   | —                                      | 76                                      | 76                         | 76              | 116             | —                                       | 160                                     | 160                        | —                          |
| EPM1270<br>EPM1270G | —                                      | —                                       | —                          | —               | 116             | —                                       | 212                                     | 212                        | —                          |
| EPM2210<br>EPM2210G | —                                      | —                                       | —                          | —               | —               | —                                       | —                                       | 204                        | 272                        |
| EPM240Z             | 54                                     | 80                                      | —                          | —               | —               | —                                       | —                                       | —                          | —                          |
| EPM570Z             | —                                      | 76                                      | —                          | —               | —               | 116                                     | 160                                     | —                          | —                          |

**Note to Table 1–3:**

(1) Packages available in lead-free versions only.

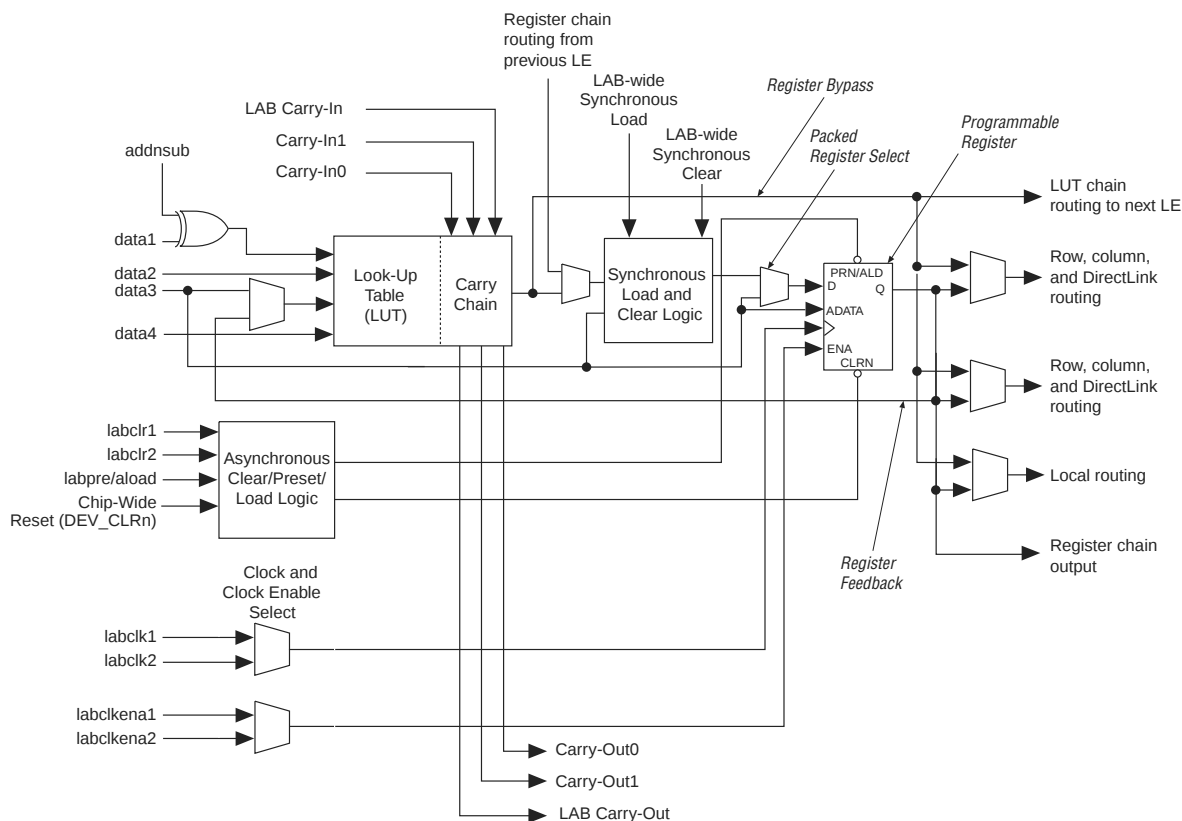
**Table 1–4.** MAX II TQFP, FineLine BGA, and Micro FineLine BGA Package Sizes

| Package                     | 68-Pin<br>Micro<br>FineLine<br>BGA | 100-Pin<br>Micro<br>FineLine<br>BGA | 100-Pin<br>FineLine<br>BGA | 100-Pin<br>TQFP | 144-Pin<br>TQFP | 144-Pin<br>Micro<br>FineLine<br>BGA | 256-Pin<br>Micro<br>FineLine<br>BGA | 256-Pin<br>FineLine<br>BGA | 324-Pin<br>FineLine<br>BGA |
|-----------------------------|------------------------------------|-------------------------------------|----------------------------|-----------------|-----------------|-------------------------------------|-------------------------------------|----------------------------|----------------------------|
| Pitch (mm)                  | 0.5                                | 0.5                                 | 1                          | 0.5             | 0.5             | 0.5                                 | 0.5                                 | 1                          | 1                          |
| Area (mm <sup>2</sup> )     | 25                                 | 36                                  | 121                        | 256             | 484             | 49                                  | 121                                 | 289                        | 361                        |
| Length × width<br>(mm × mm) | 5 × 5                              | 6 × 6                               | 11 × 11                    | 16 × 16         | 22 × 22         | 7 × 7                               | 11 × 11                             | 17 × 17                    | 19 × 19                    |

**Table 1-6.** Document Revision History

| Date and Revision             | Changes Made                           | Summary of Changes |
|-------------------------------|----------------------------------------|--------------------|
| June 2005,<br>version 1.3     | ■ Updated timing numbers in Table 1-1. | —                  |
| December 2004,<br>version 1.2 | ■ Updated timing numbers in Table 1-1. | —                  |
| June 2004,<br>version 1.1     | ■ Updated timing numbers in Table 1-1. | —                  |

Figure 2-6. MAX II LE

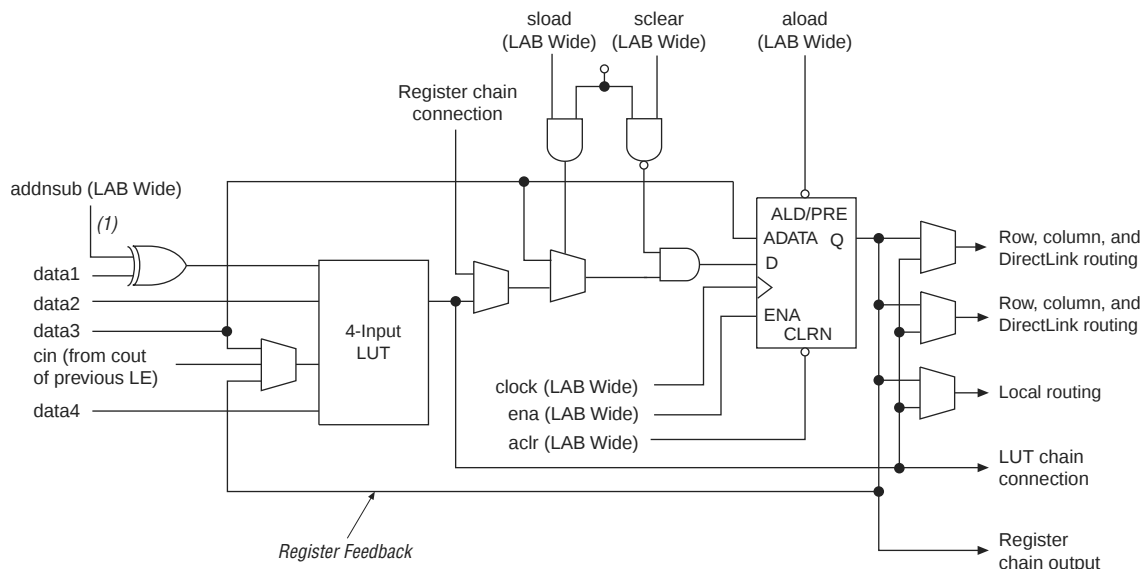


Each LE's programmable register can be configured for D, T, JK, or SR operation. Each register has data, true asynchronous load data, clock, clock enable, clear, and asynchronous load/preset inputs. Global signals, general-purpose I/O pins, or any LE can drive the register's clock and clear control signals. Either general-purpose I/O pins or LEs can drive the clock enable, preset, asynchronous load, and asynchronous data. The asynchronous load data input comes from the data3 input of the LE. For combinational functions, the LUT output bypasses the register and drives directly to the LE outputs.

Each LE has three outputs that drive the local, row, and column routing resources. The LUT or register output can drive these three outputs independently. Two LE outputs drive column or row and DirectLink routing connections and one drives local interconnect resources. This allows the LUT to drive one output while the register drives another output. This register packing feature improves device utilization because the device can use the register and the LUT for unrelated functions. Another special packing mode allows the register output to feed back into the LUT of the same LE so that the register is packed with its own fan-out LUT. This provides another mechanism for improved fitting. The LE can also drive out registered and unregistered versions of the LUT output.

The normal mode is suitable for general logic applications and combinational functions. In normal mode, four data inputs from the LAB local interconnect are inputs to a four-input LUT (see Figure 2-7). The Quartus II Compiler automatically selects the carry-in or the data3 signal as one of the inputs to the LUT. Each LE can use LUT chain connections to drive its combinational output directly to the next LE in the LAB. Asynchronous load data for the register comes from the data3 input of the LE. LEs in normal mode support packed registers.

**Figure 2-7. LE in Normal Mode**



(1) This signal is only allowed in normal mode if the LE is at the end of an adder/subtractor chain.

The dynamic arithmetic mode is ideal for implementing adders, counters, accumulators, wide parity functions, and comparators. An LE in dynamic arithmetic mode uses four 2-input LUTs configurable as a dynamic adder/subtractor. The first two 2-input LUTs compute two summations based on a possible carry-in of 1 or 0; the other two LUTs generate carry outputs for the two chains of the carry-select circuitry. As shown in Figure 2-8, the LAB carry-in signal selects either the carry-in0 or carry-in1 chain. The selected chain's logic level in turn determines which parallel sum is generated as a combinational or registered output. For example, when implementing an adder, the sum output is the selection of two possible calculated sums:

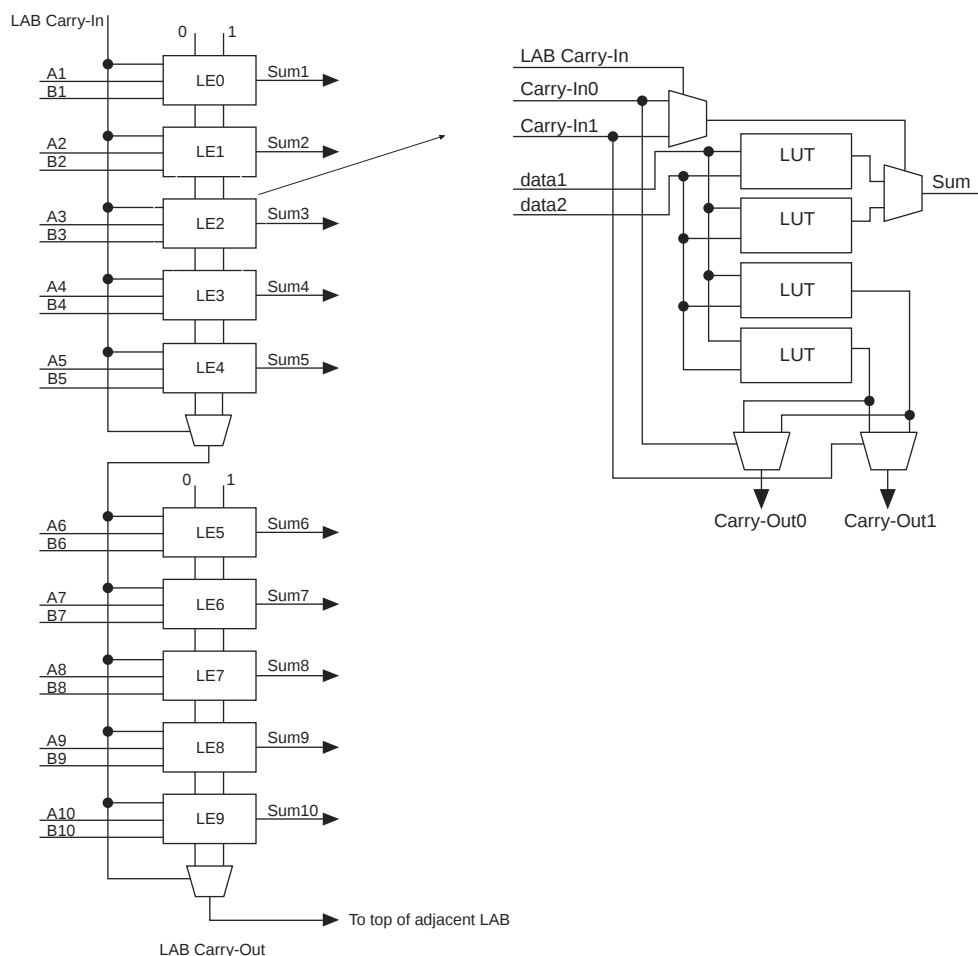
or

```
data1 + data2 + carry-in1
```

The speed advantage of the carry-select chain is in the parallel precomputation of carry chains. Since the LAB carry-in selects the precomputed carry chain, not every LE is in the critical path. Only the propagation delays between LAB carry-in generation (LE 5 and LE 10) are now part of the critical path. This feature allows the MAX II architecture to implement high-speed counters, adders, multipliers, parity functions, and comparators of arbitrary width.

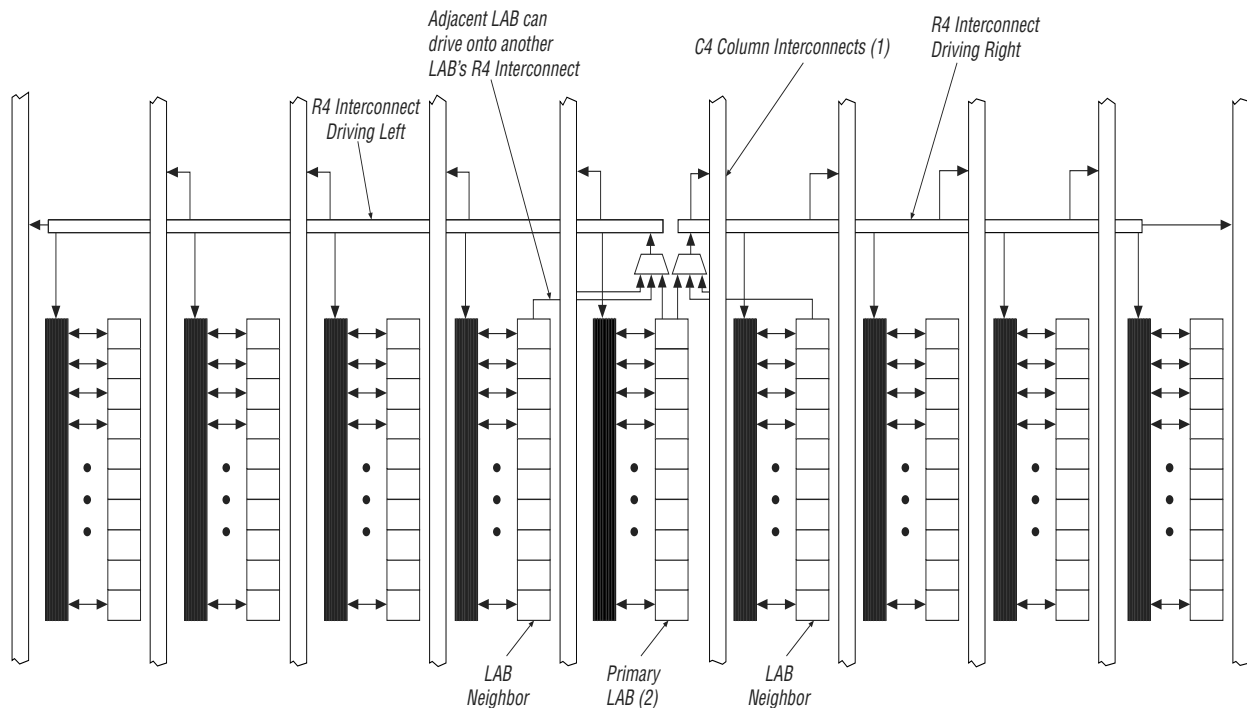
Figure 2-9 shows the carry-select circuitry in an LAB for a 10-bit full adder. One portion of the LUT generates the sum of two bits using the input signals and the appropriate carry-in bit; the sum is routed to the output of the LE. The register can be bypassed for simple adders or used for accumulator functions. Another portion of the LUT generates carry-out bits. An LAB-wide carry-in bit selects which chain is used for the addition of given inputs. The carry-in signal for each chain, carry-in0 or carry-in1, selects the carry-out to carry forward to the carry-in signal of the next-higher-order bit. The final carry-out signal is routed to an LE, where it is fed to local, row, or column interconnects.

**Figure 2-9.** Carry-Select Chain



The R4 interconnects span four LABs and are used for fast row connections in a four-LAB region. Every LAB has its own set of R4 interconnects to drive either left or right. Figure 2-10 shows R4 interconnect connections from an LAB. R4 interconnects can drive and be driven by row IOEs. For LAB interfacing, a primary LAB or horizontal LAB neighbor can drive a given R4 interconnect. For R4 interconnects that drive to the right, the primary LAB and right neighbor can drive on to the interconnect. For R4 interconnects that drive to the left, the primary LAB and its left neighbor can drive on to the interconnect. R4 interconnects can drive other R4 interconnects to extend the range of LABs they can drive. R4 interconnects can also drive C4 interconnects for connections from one row to another.

**Figure 2-10.** R4 Interconnect Connections



**Notes to Figure 2-10:**

- (1) C4 interconnects can drive R4 interconnects.
- (2) This pattern is repeated for every LAB in the LAB row.

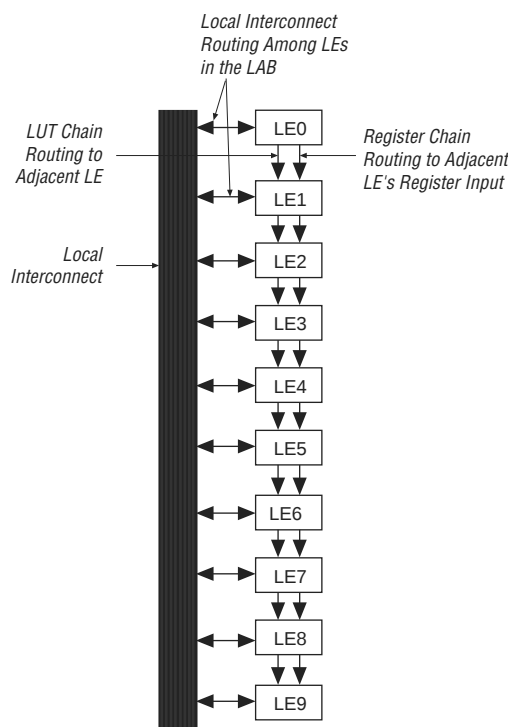
The column interconnect operates similarly to the row interconnect. Each column of LABs is served by a dedicated column interconnect, which vertically routes signals to and from LABs and row and column IOEs. These column resources include:

- LUT chain interconnects within an LAB
- Register chain interconnects within an LAB
- C4 interconnects traversing a distance of four LABs in an up and down direction

MAX II devices include an enhanced interconnect structure within LABs for routing LE output to LE input connections faster using LUT chain connections and register chain connections. The LUT chain connection allows the combinational output of an LE to directly drive the fast input of the LE right below it, bypassing the local interconnect. These resources can be used as a high-speed connection for wide fan-in

functions from LE 1 to LE 10 in the same LAB. The register chain connection allows the register output of one LE to connect directly to the register input of the next LE in the LAB for fast shift registers. The Quartus II Compiler automatically takes advantage of these resources to improve utilization and performance. Figure 2-11 shows the LUT chain and register chain interconnects.

**Figure 2-11.** LUT Chain and Register Chain Interconnects



The C4 interconnects span four LABs up or down from a source LAB. Every LAB has its own set of C4 interconnects to drive either up or down. Figure 2-12 shows the C4 interconnect connections from an LAB in a column. The C4 interconnects can drive and be driven by column and row IOEs. For LAB interconnection, a primary LAB or its vertical LAB neighbor can drive a given C4 interconnect. C4 interconnects can drive each other to extend their range as well as drive row interconnects for column-to-column connections.

The UFM block communicates with the logic array similar to LAB-to-LAB interfaces. The UFM block connects to row and column interconnects and has local interconnect regions driven by row and column interconnects. This block also has DirectLink interconnects for fast connections to and from a neighboring LAB. For more information about the UFM interface to the logic array, see “User Flash Memory Block” on page 2-18.

Table 2-2 shows the MAX II device routing scheme.

**Table 2-2.** MAX II Device Routing Scheme

| Source                  | Destination |                |           |                |        |        |    |           |            |         |              |
|-------------------------|-------------|----------------|-----------|----------------|--------|--------|----|-----------|------------|---------|--------------|
|                         | LUT Chain   | Register Chain | Local (1) | DirectLink (1) | R4 (1) | C4 (1) | LE | UFM Block | Column IOE | Row IOE | Fast I/O (1) |
| LUT Chain               | —           | —              | —         | —              | —      | —      | ✓  | —         | —          | —       | —            |
| Register Chain          | —           | —              | —         | —              | —      | —      | ✓  | —         | —          | —       | —            |
| Local Interconnect      | —           | —              | —         | —              | —      | —      | ✓  | ✓         | ✓          | ✓       | —            |
| DirectLink Interconnect | —           | —              | ✓         | —              | —      | —      | —  | —         | —          | —       | —            |
| R4 Interconnect         | —           | —              | ✓         | —              | ✓      | ✓      | —  | —         | —          | —       | —            |
| C4 Interconnect         | —           | —              | ✓         | —              | ✓      | ✓      | —  | —         | —          | —       | —            |
| LE                      | ✓           | ✓              | ✓         | ✓              | ✓      | ✓      | —  | —         | ✓          | ✓       | ✓            |
| UFM Block               | —           | —              | ✓         | ✓              | ✓      | ✓      | —  | —         | —          | —       | —            |
| Column IOE              | —           | —              | —         | —              | —      | ✓      | —  | —         | —          | —       | —            |
| Row IOE                 | —           | —              | —         | ✓              | ✓      | ✓      | —  | —         | —          | —       | —            |

**Note to Table 2-2:**

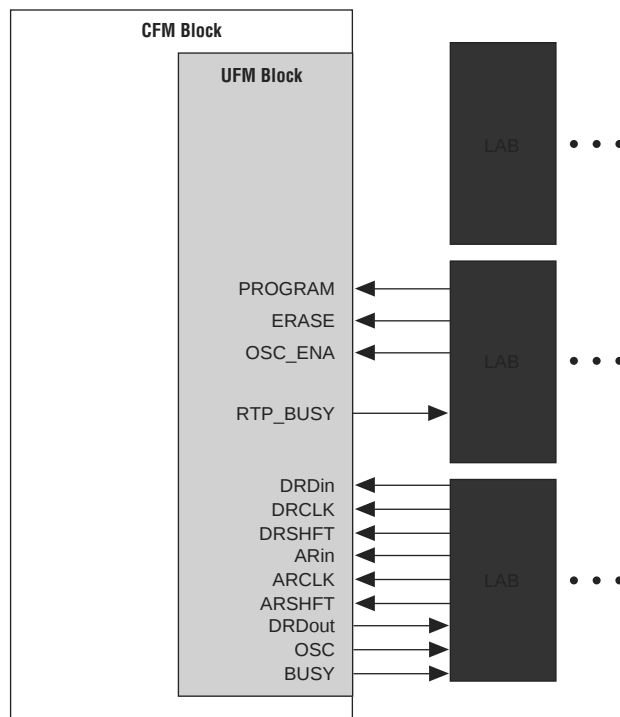
(1) These categories are interconnects.

## Global Signals

Each MAX II device has four dual-purpose dedicated clock pins (GCLK[3..0], two pins on the left side and two pins on the right side) that drive the global clock network for clocking, as shown in Figure 2-13. These four pins can also be used as general-purpose I/O if they are not used to drive the global clock network.

The four global clock lines in the global clock network drive throughout the entire device. The global clock network can provide clocks for all resources within the device including LEs, LAB local interconnect, IOEs, and the UFM block. The global clock lines can also be used for global control signals, such as clock enables, synchronous or asynchronous clears, presets, output enables, or protocol control signals such as TRDY and IRDY for PCI. Internal logic can drive the global clock network for internally-generated global clocks and control signals. Figure 2-13 shows the various sources that drive the global clock network.

**Figure 2-16.** EPM240 UFM Block LAB Row Interface *(Note 1)*



**Note to Figure 2-16:**

- (1) The UFM block inputs and outputs can drive to/from all types of interconnects, not only DirectLink interconnects from adjacent row LABs.

**Table 2-6.** Programmable Drive Strength (*Note 1*)

| I/O Standard        | IOH/IOL Current Strength Setting (mA) |
|---------------------|---------------------------------------|
| 3.3-V LVTTTL        | 16                                    |
|                     | 8                                     |
| 3.3-V LVCMOS        | 8                                     |
|                     | 4                                     |
| 2.5-V LVTTTL/LVCMOS | 14                                    |
|                     | 7                                     |
| 1.8-V LVTTTL/LVCMOS | 6                                     |
|                     | 3                                     |
| 1.5-V LVCMOS        | 4                                     |
|                     | 2                                     |

**Note to Table 2-6:**

- (1) The  $I_{OH}$  current strength numbers shown are for a condition of a  $V_{OUT} = V_{OH}$  minimum, where the  $V_{OH}$  minimum is specified by the I/O standard. The  $I_{OL}$  current strength numbers shown are for a condition of a  $V_{OUT} = V_{OL}$  maximum, where the  $V_{OL}$  maximum is specified by the I/O standard. For 2.5-V LVTTTL/LVCMOS, the  $I_{OH}$  condition is  $V_{OUT} = 1.7$  V and the  $I_{OL}$  condition is  $V_{OUT} = 0.7$  V.

## Slew-Rate Control

The output buffer for each MAX II device I/O pin has a programmable output slew-rate control that can be configured for low noise or high-speed performance. A faster slew rate provides high-speed transitions for high-performance systems. However, these fast transitions may introduce noise transients into the system. A slow slew rate reduces system noise, but adds a nominal output delay to rising and falling edges. The lower the voltage standard (for example, 1.8-V LVTTTL) the larger the output delay when slow slew is enabled. Each I/O pin has an individual slew-rate control, allowing the designer to specify the slew rate on a pin-by-pin basis. The slew-rate control affects both the rising and falling edges.

## Open-Drain Output

MAX II devices provide an optional open-drain (equivalent to open-collector) output for each I/O pin. This open-drain output enables the device to provide system-level control signals (for example, interrupt and write enable signals) that can be asserted by any of several devices. This output can also provide an additional wired-OR plane.

## Programmable Ground Pins

Each unused I/O pin on MAX II devices can be used as an additional ground pin. This programmable ground feature does not require the use of the associated LEs in the device. In the Quartus II software, unused pins can be set as programmable GND on a global default basis or they can be individually assigned. Unused pins also have the option of being set as tri-stated input pins.

## 4. Hot Socketing and Power-On Reset in MAX II Devices

MII51004-2.1

### Introduction

MAX® II devices offer hot socketing, also known as hot plug-in or hot swap, and power sequencing support. Designers can insert or remove a MAX II board in a system during operation without undesirable effects to the system bus. The hot socketing feature removes some of the difficulties designers face when using components on printed circuit boards (PCBs) that contain a mixture of 3.3-, 2.5-, 1.8-, and 1.5-V devices.

The MAX II device hot socketing feature provides:

- Board or device insertion and removal
- Support for any power-up sequence
- Non-intrusive I/O buffers to system buses during hot insertion

This chapter contains the following sections:

- “MAX II Hot-Socketing Specifications” on page 4-1
- “Power-On Reset Circuitry” on page 4-5

### MAX II Hot-Socketing Specifications

MAX II devices offer all three of the features required for the hot-socketing capability listed above without any external components or special design requirements. The following are hot-socketing specifications:

- The device can be driven before and during power-up or power-down without any damage to the device itself.
- I/O pins remain tri-stated during power-up. The device does not drive out before or during power-up, thereby affecting other buses in operation.
- Signal pins do not drive the  $V_{CCIO}$  or  $V_{CCINT}$  power supplies. External input signals to device I/O pins do not power the device  $V_{CCIO}$  or  $V_{CCINT}$  power supplies via internal paths. This is true if the  $V_{CCINT}$  and the  $V_{CCIO}$  supplies are held at GND.



Altera uses GND as reference for the hot-socketing and I/O buffers circuitry designs. You must connect the GND between boards before connecting the  $V_{CCINT}$  and the  $V_{CCIO}$  power supplies to ensure device reliability and compliance to the hot-socketing specifications.

### Devices Can Be Driven before Power-Up

Signals can be driven into the MAX II device I/O pins and  $GCLK[3..0]$  pins before or during power-up or power-down without damaging the device. MAX II devices support any power-up or power-down sequence ( $V_{CCIO1}$ ,  $V_{CCIO2}$ ,  $V_{CCIO3}$ ,  $V_{CCIO4}$ ,  $V_{CCINT}$ ), simplifying the system-level design.

## Recommended Operating Conditions

Table 5–2 shows the MAX II device family recommended operating conditions.

**Table 5–2.** MAX II Device Recommended Operating Conditions

| Symbol          | Parameter                                       | Conditions                  | Minimum | Maximum    | Unit |
|-----------------|-------------------------------------------------|-----------------------------|---------|------------|------|
| $V_{CCINT}$ (1) | 3.3-V supply voltage for internal logic and ISP | MAX II devices              | 3.00    | 3.60       | V    |
|                 | 2.5-V supply voltage for internal logic and ISP | MAX II devices              | 2.375   | 2.625      | V    |
|                 | 1.8-V supply voltage for internal logic and ISP | MAX IIG and MAX IIZ devices | 1.71    | 1.89       | V    |
| $V_{CCIO}$ (1)  | Supply voltage for I/O buffers, 3.3-V operation | —                           | 3.00    | 3.60       | V    |
|                 | Supply voltage for I/O buffers, 2.5-V operation | —                           | 2.375   | 2.625      | V    |
|                 | Supply voltage for I/O buffers, 1.8-V operation | —                           | 1.71    | 1.89       | V    |
|                 | Supply voltage for I/O buffers, 1.5-V operation | —                           | 1.425   | 1.575      | V    |
| $V_I$           | Input voltage                                   | (2), (3), (4)               | –0.5    | 4.0        | V    |
| $V_O$           | Output voltage                                  | —                           | 0       | $V_{CCIO}$ | V    |
| $T_J$           | Operating junction temperature                  | Commercial range            | 0       | 85         | °C   |
|                 |                                                 | Industrial range            | –40     | 100        | °C   |
|                 |                                                 | Extended range (5)          | –40     | 125        | °C   |

**Notes to Table 5–2:**

- (1) MAX II device in-system programming and/or user flash memory (UFM) programming via JTAG or logic array is not guaranteed outside the recommended operating conditions (for example, if brown-out occurs in the system during a potential write/program sequence to the UFM, users are recommended to read back UFM contents and verify against the intended write data).
- (2) Minimum DC input is –0.5 V. During transitions, the inputs may undershoot to –2.0 V for input currents less than 100 mA and periods shorter than 20 ns.
- (3) During transitions, the inputs may overshoot to the voltages shown in the following table based upon input duty cycle. The DC case is equivalent to 100% duty cycle. For more information about 5.0-V tolerance, refer to the *Using MAX II Devices in Multi-Voltage Systems* chapter in the *MAX II Device Handbook*.

| $V_{IN}$ | Max. Duty Cycle |
|----------|-----------------|
| 4.0 V    | 100% (DC)       |
| 4.1      | 90%             |
| 4.2      | 50%             |
| 4.3      | 30%             |
| 4.4      | 17%             |
| 4.5      | 10%             |
- (4) All pins, including clock, I/O, and JTAG pins, may be driven before  $V_{CCINT}$  and  $V_{CCIO}$  are powered.
- (5) For the extended temperature range of 100 to 125° C, MAX II UFM programming (erase/write) is only supported via the JTAG interface. UFM programming via the logic array interface is not guaranteed in this range.

## Programming/Erasure Specifications

Table 5–3 shows the MAX II device family programming/erasure specifications.

**Table 5–3.** MAX II Device Programming/Erasure Specifications

| Parameter                  | Minimum | Typical | Maximum | Unit   |
|----------------------------|---------|---------|---------|--------|
| Erase and reprogram cycles | —       | —       | 100 (1) | Cycles |

**Note to Table 5–3:**

(1) This specification applies to the UFM and configuration flash memory (CFM) blocks.

## DC Electrical Characteristics

Table 5–4 shows the MAX II device family DC electrical characteristics.

**Table 5–4.** MAX II Device DC Electrical Characteristics (Note 1) (Part 1 of 2)

| Symbol            | Parameter                                                                    | Conditions                      | Minimum | Typical | Maximum | Unit      |
|-------------------|------------------------------------------------------------------------------|---------------------------------|---------|---------|---------|-----------|
| $I_I$             | Input pin leakage current                                                    | $V_I = V_{CCIO}$ max to 0 V (2) | –10     | —       | 10      | $\mu A$   |
| $I_{OZ}$          | Tri-stated I/O pin leakage current                                           | $V_O = V_{CCIO}$ max to 0 V (2) | –10     | —       | 10      | $\mu A$   |
| $I_{CCSTANDBY}$   | $V_{CCINT}$ supply current (standby) (3)                                     | MAX II devices                  | —       | 12      | —       | mA        |
|                   |                                                                              | MAX IIG devices                 | —       | 2       | —       | mA        |
|                   |                                                                              | EPM240Z (Commercial grade) (4)  | —       | 25      | 90      | $\mu A$   |
|                   |                                                                              | EPM240Z (Industrial grade) (5)  | —       | 25      | 139     | $\mu A$   |
|                   |                                                                              | EPM570Z (Commercial grade) (4)  | —       | 27      | 96      | $\mu A$   |
|                   |                                                                              | EPM570Z (Industrial grade) (5)  | —       | 27      | 152     | $\mu A$   |
| $V_{SCHMITT}$ (6) | Hysteresis for Schmitt trigger input (7)                                     | $V_{CCIO} = 3.3$ V              | —       | 400     | —       | mV        |
|                   |                                                                              | $V_{CCIO} = 2.5$ V              | —       | 190     | —       | mV        |
| $I_{CCPOWERUP}$   | $V_{CCINT}$ supply current during power-up (8)                               | MAX II devices                  | —       | 55      | —       | mA        |
|                   |                                                                              | MAX IIG and MAX IIZ devices     | —       | 40      | —       | mA        |
| $R_{PULLUP}$      | Value of I/O pin pull-up resistor during user mode and in-system programming | $V_{CCIO} = 3.3$ V (9)          | 5       | —       | 25      | $k\Omega$ |
|                   |                                                                              | $V_{CCIO} = 2.5$ V (9)          | 10      | —       | 40      | $k\Omega$ |
|                   |                                                                              | $V_{CCIO} = 1.8$ V (9)          | 25      | —       | 60      | $k\Omega$ |
|                   |                                                                              | $V_{CCIO} = 1.5$ V (9)          | 45      | —       | 95      | $k\Omega$ |

**Table 5-4.** MAX II Device DC Electrical Characteristics (Note 1) (Part 2 of 2)

| Symbol       | Parameter                                                 | Conditions | Minimum | Typical | Maximum | Unit    |
|--------------|-----------------------------------------------------------|------------|---------|---------|---------|---------|
| $I_{PULLUP}$ | I/O pin pull-up resistor current when I/O is unprogrammed | —          | —       | —       | 300     | $\mu A$ |
| $C_{IO}$     | Input capacitance for user I/O pin                        | —          | —       | —       | 8       | pF      |
| $C_{GCLK}$   | Input capacitance for dual-purpose GCLK/user I/O pin      | —          | —       | —       | 8       | pF      |

**Notes to Table 5-4:**

- (1) Typical values are for  $T_A = 25^\circ C$ ,  $V_{CCINT} = 3.3$  or  $2.5$  V, and  $V_{CCIO} = 1.5$  V,  $1.8$  V,  $2.5$  V, or  $3.3$  V.
- (2) This value is specified for normal device operation. The value may vary during power-up. This applies for all  $V_{CCIO}$  settings ( $3.3$ ,  $2.5$ ,  $1.8$ , and  $1.5$  V).
- (3)  $V_I =$  ground, no load, no toggling inputs.
- (4) Commercial temperature ranges from  $0^\circ C$  to  $85^\circ C$  with maximum current at  $85^\circ C$ .
- (5) Industrial temperature ranges from  $-40^\circ C$  to  $100^\circ C$  with maximum current at  $100^\circ C$ .
- (6) This value applies to commercial and industrial range devices. For extended temperature range devices, the  $V_{SCHMITT}$  typical value is  $300$  mV for  $V_{CCIO} = 3.3$  V and  $120$  mV for  $V_{CCIO} = 2.5$  V.
- (7) The TCK input is susceptible to high pulse glitches when the input signal fall time is greater than  $200$  ns for all I/O standards.
- (8) This is a peak current value with a maximum duration of  $t_{CONFIG}$  time.
- (9) Pin pull-up resistance values will lower if an external source drives the pin higher than  $V_{CCIO}$ .

**Table 5-6.** 3.3-V LVCMOS Specifications (Part 2 of 2)

| Symbol   | Parameter                 | Conditions                                        | Minimum          | Maximum | Unit |
|----------|---------------------------|---------------------------------------------------|------------------|---------|------|
| $V_{OH}$ | High-level output voltage | $V_{CCIO} = 3.0$ ,<br>$IOH = -0.1 \text{ mA}$ (1) | $V_{CCIO} - 0.2$ | —       | V    |
| $V_{OL}$ | Low-level output voltage  | $V_{CCIO} = 3.0$ ,<br>$IOL = 0.1 \text{ mA}$ (1)  | —                | 0.2     | V    |

**Table 5-7.** 2.5-V I/O Specifications

| Symbol     | Parameter                 | Conditions                  | Minimum | Maximum | Unit |
|------------|---------------------------|-----------------------------|---------|---------|------|
| $V_{CCIO}$ | I/O supply voltage        | —                           | 2.375   | 2.625   | V    |
| $V_{IH}$   | High-level input voltage  | —                           | 1.7     | 4.0     | V    |
| $V_{IL}$   | Low-level input voltage   | —                           | -0.5    | 0.7     | V    |
| $V_{OH}$   | High-level output voltage | $IOH = -0.1 \text{ mA}$ (1) | 2.1     | —       | V    |
|            |                           | $IOH = -1 \text{ mA}$ (1)   | 2.0     | —       | V    |
|            |                           | $IOH = -2 \text{ mA}$ (1)   | 1.7     | —       | V    |
| $V_{OL}$   | Low-level output voltage  | $IOL = 0.1 \text{ mA}$ (1)  | —       | 0.2     | V    |
|            |                           | $IOL = 1 \text{ mA}$ (1)    | —       | 0.4     | V    |
|            |                           | $IOL = 2 \text{ mA}$ (1)    | —       | 0.7     | V    |

**Table 5-8.** 1.8-V I/O Specifications

| Symbol     | Parameter                 | Conditions                | Minimum                | Maximum                | Unit |
|------------|---------------------------|---------------------------|------------------------|------------------------|------|
| $V_{CCIO}$ | I/O supply voltage        | —                         | 1.71                   | 1.89                   | V    |
| $V_{IH}$   | High-level input voltage  | —                         | $0.65 \times V_{CCIO}$ | 2.25 (2)               | V    |
| $V_{IL}$   | Low-level input voltage   | —                         | -0.3                   | $0.35 \times V_{CCIO}$ | V    |
| $V_{OH}$   | High-level output voltage | $IOH = -2 \text{ mA}$ (1) | $V_{CCIO} - 0.45$      | —                      | V    |
| $V_{OL}$   | Low-level output voltage  | $IOL = 2 \text{ mA}$ (1)  | —                      | 0.45                   | V    |

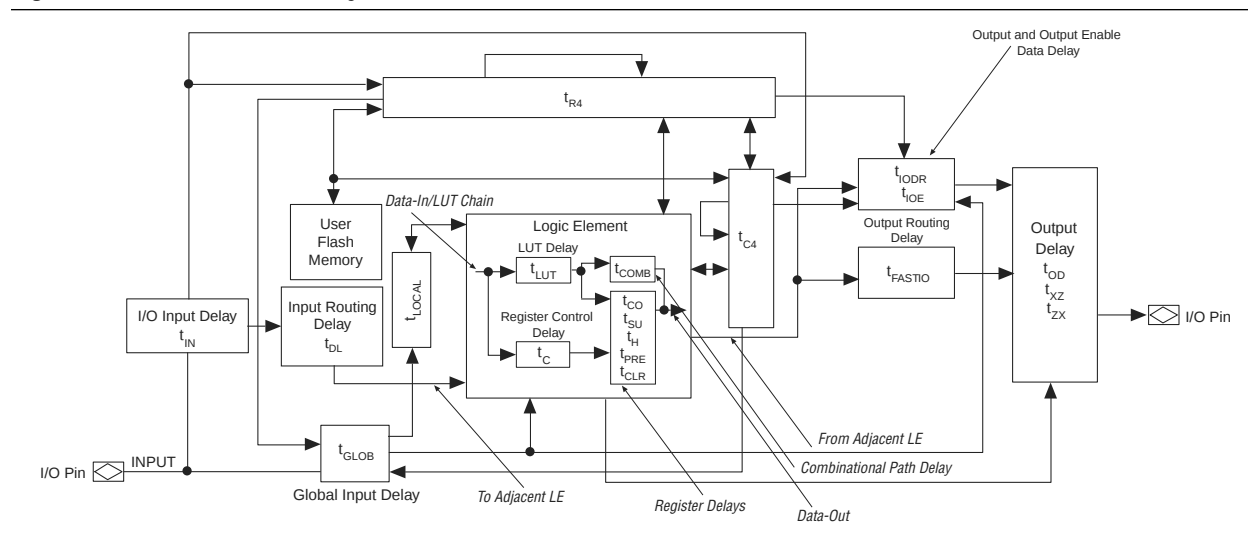
**Table 5-9.** 1.5-V I/O Specifications

| Symbol     | Parameter                 | Conditions                | Minimum                | Maximum                | Unit |
|------------|---------------------------|---------------------------|------------------------|------------------------|------|
| $V_{CCIO}$ | I/O supply voltage        | —                         | 1.425                  | 1.575                  | V    |
| $V_{IH}$   | High-level input voltage  | —                         | $0.65 \times V_{CCIO}$ | $V_{CCIO} + 0.3$ (2)   | V    |
| $V_{IL}$   | Low-level input voltage   | —                         | -0.3                   | $0.35 \times V_{CCIO}$ | V    |
| $V_{OH}$   | High-level output voltage | $IOH = -2 \text{ mA}$ (1) | $0.75 \times V_{CCIO}$ | —                      | V    |
| $V_{OL}$   | Low-level output voltage  | $IOL = 2 \text{ mA}$ (1)  | —                      | $0.25 \times V_{CCIO}$ | V    |

**Notes to Table 5-5 through Table 5-9:**

- (1) This specification is supported across all the programmable drive strength settings available for this I/O standard, as shown in the *MAX II Architecture* chapter (*I/O Structure* section) in the *MAX II Device Handbook*.
- (2) This maximum  $V_{IH}$  reflects the JEDEC specification. The MAX II input buffer can tolerate a  $V_{IH}$  maximum of 4.0, as specified by the  $V_I$  parameter in Table 5-2.

**Figure 5-2.** MAX II Device Timing Model



The timing characteristics of any signal path can be derived from the timing model and parameters of a particular device. External timing parameters, which represent pin-to-pin timing delays, can be calculated as the sum of internal parameters.

Refer to the *Understanding Timing in MAX II Devices* chapter in the *MAX II Device Handbook* for more information.

This section describes and specifies the performance, internal, external, and UFM timing specifications. All specifications are representative of the worst-case supply voltage and junction temperature conditions.

## Preliminary and Final Timing

Timing models can have either preliminary or final status. The Quartus II software issues an informational message during the design compilation if the timing models are preliminary. Table 5-13 shows the status of the MAX II device timing models.

Preliminary status means the timing model is subject to change. Initially, timing numbers are created using simulation results, process data, and other known parameters. These tests are used to make the preliminary numbers as close to the actual timing parameters as possible.

Final timing numbers are based on actual device operation and testing. These numbers reflect the actual performance of the device under the worst-case voltage and junction temperature conditions.

**Table 5-13.** MAX II Device Timing Model Status (Part 1 of 2)

| Device      | Preliminary | Final |
|-------------|-------------|-------|
| EPM240      | —           | ✓     |
| EPM240Z (1) | —           | ✓     |
| EPM570      | —           | ✓     |
| EPM570Z (1) | —           | ✓     |

## Internal Timing Parameters

Internal timing parameters are specified on a speed grade basis independent of device density. Table 5-15 through Table 5-22 describe the MAX II device internal timing microparameters for logic elements (LEs), input/output elements (IOEs), UFM blocks, and MultiTrack interconnects. The timing values for -3, -4, and -5 speed grades shown in Table 5-15 through Table 5-22 are based on an EPM1270 device target, while -6, -7, and -8 speed grade values are based on an EPM570Z device target.



For more explanations and descriptions about each internal timing microparameters symbol, refer to the *Understanding Timing in MAX II Devices* chapter in the *MAX II Device Handbook*.

**Table 5-15.** LE Internal Timing Microparameters

| Symbol             | Parameter                           | MAX II / MAX IIG |     |                |       |                |       | MAX IIZ        |       |                |       |                |       | Unit |
|--------------------|-------------------------------------|------------------|-----|----------------|-------|----------------|-------|----------------|-------|----------------|-------|----------------|-------|------|
|                    |                                     | -3 Speed Grade   |     | -4 Speed Grade |       | -5 Speed Grade |       | -6 Speed Grade |       | -7 Speed Grade |       | -8 Speed Grade |       |      |
|                    |                                     | Min              | Max | Min            | Max   | Min            | Max   | Min            | Max   | Min            | Max   | Min            | Max   |      |
| t <sub>LUT</sub>   | LE combinational LUT delay          | —                | 571 | —              | 742   | —              | 914   | —              | 1,215 | —              | 2,247 | —              | 2,247 | ps   |
| t <sub>COMB</sub>  | Combinational path delay            | —                | 147 | —              | 192   | —              | 236   | —              | 243   | —              | 305   | —              | 309   | ps   |
| t <sub>CLR</sub>   | LE register clear delay             | 238              | —   | 309            | —     | 381            | —     | 401            | —     | 541            | —     | 545            | —     | ps   |
| t <sub>PRE</sub>   | LE register preset delay            | 238              | —   | 309            | —     | 381            | —     | 401            | —     | 541            | —     | 545            | —     | ps   |
| t <sub>SU</sub>    | LE register setup time before clock | 208              | —   | 271            | —     | 333            | —     | 260            | —     | 319            | —     | 321            | —     | ps   |
| t <sub>H</sub>     | LE register hold time after clock   | 0                | —   | 0              | —     | 0              | —     | 0              | —     | 0              | —     | 0              | —     | ps   |
| t <sub>CO</sub>    | LE register clock-to-output delay   | —                | 235 | —              | 305   | —              | 376   | —              | 380   | —              | 489   | —              | 494   | ps   |
| t <sub>CLKHL</sub> | Minimum clock high or low time      | 166              | —   | 216            | —     | 266            | —     | 253            | —     | 335            | —     | 339            | —     | ps   |
| t <sub>C</sub>     | Register control delay              | —                | 857 | —              | 1,114 | —              | 1,372 | —              | 1,356 | —              | 1,722 | —              | 1,741 | ps   |

**Table 5-17.**  $t_{ZX}$  IOE Microparameter Adders for Fast Slew Rate (Part 2 of 2)

| Standard     |       | MAX II / MAX IIG |       |                |       |                |       | MAX IIZ        |     |                |     |                |     | Unit |
|--------------|-------|------------------|-------|----------------|-------|----------------|-------|----------------|-----|----------------|-----|----------------|-----|------|
|              |       | −3 Speed Grade   |       | −4 Speed Grade |       | −5 Speed Grade |       | −6 Speed Grade |     | −7 Speed Grade |     | −8 Speed Grade |     |      |
|              |       | Min              | Max   | Min            | Max   | Min            | Max   | Min            | Max | Min            | Max | Min            | Max |      |
| 1.5-V LVCMOS | 4 mA  | —                | 1,118 | —              | 1,454 | —              | 1,789 | —              | 580 | —              | 588 | —              | 588 | ps   |
|              | 2 mA  | —                | 2,410 | —              | 3,133 | —              | 3,856 | —              | 915 | —              | 923 | —              | 923 | ps   |
| 3.3-V PCI    | 20 mA | —                | 19    | —              | 25    | —              | 31    | —              | 72  | —              | 71  | —              | 74  | ps   |

**Table 5-18.**  $t_{ZX}$  IOE Microparameter Adders for Slow Slew Rate

| Standard              |       | MAX II / MAX IIG |        |                |        |                |        | MAX IIZ        |       |                |       |                |       | Unit |
|-----------------------|-------|------------------|--------|----------------|--------|----------------|--------|----------------|-------|----------------|-------|----------------|-------|------|
|                       |       | -3 Speed Grade   |        | -4 Speed Grade |        | -5 Speed Grade |        | -6 Speed Grade |       | -7 Speed Grade |       | -8 Speed Grade |       |      |
|                       |       | Min              | Max    | Min            | Max    | Min            | Max    | Min            | Max   | Min            | Max   | Min            | Max   |      |
| 3.3-V LVTTTL          | 16 mA | —                | 6,350  | —              | 6,050  | —              | 5,749  | —              | 5,951 | —              | 5,952 | —              | 6,063 | ps   |
|                       | 8 mA  | —                | 9,383  | —              | 9,083  | —              | 8,782  | —              | 6,534 | —              | 6,533 | —              | 6,662 | ps   |
| 3.3-V LVCMOS          | 8 mA  | —                | 6,350  | —              | 6,050  | —              | 5,749  | —              | 5,951 | —              | 5,952 | —              | 6,063 | ps   |
|                       | 4 mA  | —                | 9,383  | —              | 9,083  | —              | 8,782  | —              | 6,534 | —              | 6,533 | —              | 6,662 | ps   |
| 2.5-V LVTTTL / LVCMOS | 14 mA | —                | 10,412 | —              | 10,112 | —              | 9,811  | —              | 9,110 | —              | 9,105 | —              | 9,237 | ps   |
|                       | 7 mA  | —                | 13,613 | —              | 13,313 | —              | 13,012 | —              | 9,830 | —              | 9,835 | —              | 9,977 | ps   |
| 3.3-V PCI             | 20 mA | —                | -75    | —              | -97    | —              | -120   | —              | 6,534 | —              | 6,533 | —              | 6,662 | ps   |

**Table 5-19.**  $t_{XZ}$  IOE Microparameter Adders for Fast Slew Rate

| Standard              |       | MAX II / MAX IIG |     |                |     |                |       | MAX IIZ        |     |                |     |                |     | Unit |
|-----------------------|-------|------------------|-----|----------------|-----|----------------|-------|----------------|-----|----------------|-----|----------------|-----|------|
|                       |       | -3 Speed Grade   |     | -4 Speed Grade |     | -5 Speed Grade |       | -6 Speed Grade |     | -7 Speed Grade |     | -8 Speed Grade |     |      |
|                       |       | Min              | Max | Min            | Max | Min            | Max   | Min            | Max | Min            | Max | Min            | Max |      |
| 3.3-V LVTTTL          | 16 mA | —                | 0   | —              | 0   | —              | 0     | —              | 0   | —              | 0   | —              | 0   | ps   |
|                       | 8 mA  | —                | -56 | —              | -72 | —              | -89   | —              | -69 | —              | -69 | —              | -69 | ps   |
| 3.3-V LVCMOS          | 8 mA  | —                | 0   | —              | 0   | —              | 0     | —              | 0   | —              | 0   | —              | 0   | ps   |
|                       | 4 mA  | —                | -56 | —              | -72 | —              | -89   | —              | -69 | —              | -69 | —              | -69 | ps   |
| 2.5-V LVTTTL / LVCMOS | 14 mA | —                | -3  | —              | -4  | —              | -5    | —              | -7  | —              | -11 | —              | -11 | ps   |
|                       | 7 mA  | —                | -47 | —              | -61 | —              | -75   | —              | -66 | —              | -70 | —              | -70 | ps   |
| 1.8-V LVTTTL / LVCMOS | 6 mA  | —                | 119 | —              | 155 | —              | 191   | —              | 45  | —              | 34  | —              | 37  | ps   |
|                       | 3 mA  | —                | 207 | —              | 269 | —              | 331   | —              | 34  | —              | 22  | —              | 25  | ps   |
| 1.5-V LVCMOS          | 4 mA  | —                | 606 | —              | 788 | —              | 970   | —              | 166 | —              | 154 | —              | 155 | ps   |
|                       | 2 mA  | —                | 673 | —              | 875 | —              | 1,077 | —              | 190 | —              | 177 | —              | 179 | ps   |
| 3.3-V PCI             | 20 mA | —                | 71  | —              | 93  | —              | 114   | —              | -69 | —              | -69 | —              | -69 | ps   |

**Table 5-29.** External Timing Output Delay and  $t_{OD}$  Adders for Fast Slew Rate

| I/O Standard          |       | MAX II / MAX IIG |       |                |       |                |       | MAX IIZ        |     |                |     |                |     | Unit |
|-----------------------|-------|------------------|-------|----------------|-------|----------------|-------|----------------|-----|----------------|-----|----------------|-----|------|
|                       |       | -3 Speed Grade   |       | -4 Speed Grade |       | -5 Speed Grade |       | -6 Speed Grade |     | -7 Speed Grade |     | -8 Speed Grade |     |      |
|                       |       | Min              | Max   | Min            | Max   | Min            | Max   | Min            | Max | Min            | Max | Min            | Max |      |
| 3.3-V LVTTTL          | 16 mA | —                | 0     | —              | 0     | —              | 0     | —              | 0   | —              | 0   | —              | 0   | ps   |
|                       | 8 mA  | —                | 65    | —              | 84    | —              | 104   | —              | -6  | —              | -2  | —              | -3  | ps   |
| 3.3-V LVCMOS          | 8 mA  | —                | 0     | —              | 0     | —              | 0     | —              | 0   | —              | 0   | —              | 0   | ps   |
|                       | 4 mA  | —                | 65    | —              | 84    | —              | 104   | —              | -6  | —              | -2  | —              | -3  | ps   |
| 2.5-V LVTTTL / LVCMOS | 14 mA | —                | 122   | —              | 158   | —              | 195   | —              | -63 | —              | -71 | —              | -88 | ps   |
|                       | 7 mA  | —                | 193   | —              | 251   | —              | 309   | —              | 10  | —              | -1  | —              | 1   | ps   |
| 1.8-V LVTTTL / LVCMOS | 6 mA  | —                | 568   | —              | 738   | —              | 909   | —              | 128 | —              | 118 | —              | 118 | ps   |
|                       | 3 mA  | —                | 654   | —              | 850   | —              | 1,046 | —              | 352 | —              | 327 | —              | 332 | ps   |
| 1.5-V LVCMOS          | 4 mA  | —                | 1,059 | —              | 1,376 | —              | 1,694 | —              | 421 | —              | 400 | —              | 400 | ps   |
|                       | 2 mA  | —                | 1,167 | —              | 1,517 | —              | 1,867 | —              | 757 | —              | 743 | —              | 743 | ps   |
| 3.3-V PCI             | 20 mA | —                | 3     | —              | 4     | —              | 5     | —              | -6  | —              | -2  | —              | -3  | ps   |

**Table 5-30.** External Timing Output Delay and  $t_{OD}$  Adders for Slow Slew Rate

| I/O Standard           |       | MAX II / MAX IIG |        |                |        |                |        | MAX IIZ        |        |                |        |                |        | Unit |
|------------------------|-------|------------------|--------|----------------|--------|----------------|--------|----------------|--------|----------------|--------|----------------|--------|------|
|                        |       | -3 Speed Grade   |        | -4 Speed Grade |        | -5 Speed Grade |        | -6 Speed Grade |        | -7 Speed Grade |        | -8 Speed Grade |        |      |
|                        |       | Min              | Max    | Min            | Max    | Min            | Max    | Min            | Max    | Min            | Max    | Min            | Max    |      |
| 3.3-V LV TTL           | 16 mA | —                | 7,064  | —              | 6,745  | —              | 6,426  | —              | 5,966  | —              | 5,992  | —              | 6,118  | ps   |
|                        | 8 mA  | —                | 7,946  | —              | 7,627  | —              | 7,308  | —              | 6,541  | —              | 6,570  | —              | 6,720  | ps   |
| 3.3-V LV CMOS          | 8 mA  | —                | 7,064  | —              | 6,745  | —              | 6,426  | —              | 5,966  | —              | 5,992  | —              | 6,118  | ps   |
|                        | 4 mA  | —                | 7,946  | —              | 7,627  | —              | 7,308  | —              | 6,541  | —              | 6,570  | —              | 6,720  | ps   |
| 2.5-V LV TTL / LV CMOS | 14 mA | —                | 10,434 | —              | 10,115 | —              | 9,796  | —              | 9,141  | —              | 9,154  | —              | 9,297  | ps   |
|                        | 7 mA  | —                | 11,548 | —              | 11,229 | —              | 10,910 | —              | 9,861  | —              | 9,874  | —              | 10,037 | ps   |
| 1.8-V LV TTL / LV CMOS | 6 mA  | —                | 22,927 | —              | 22,608 | —              | 22,289 | —              | 21,811 | —              | 21,854 | —              | 21,857 | ps   |
|                        | 3 mA  | —                | 24,731 | —              | 24,412 | —              | 24,093 | —              | 23,081 | —              | 23,034 | —              | 23,107 | ps   |
| 1.5-V LV CMOS          | 4 mA  | —                | 38,723 | —              | 38,404 | —              | 38,085 | —              | 39,121 | —              | 39,124 | —              | 39,124 | ps   |
|                        | 2 mA  | —                | 41,330 | —              | 41,011 | —              | 40,692 | —              | 40,631 | —              | 40,634 | —              | 40,634 | ps   |
| 3.3-V PCI              | 20 mA | —                | 261    | —              | 339    | —              | 418    | —              | 6,644  | —              | 6,627  | —              | 6,914  | ps   |

## Referenced Documents

This chapter references the following document:

- *Package Information* chapter in the *MAX II Device Handbook*

## Document Revision History

Table 6–1 shows the revision history for this chapter.

**Table 6–1.** Document Revision History

| Date and Revision             | Changes Made                                                     | Summary of Changes                         |
|-------------------------------|------------------------------------------------------------------|--------------------------------------------|
| August 2009,<br>version 1.6   | ■ Updated Figure 6–1.                                            | Added information for speed grade –8       |
| October 2008,<br>version 1.5  | ■ Updated New Document Format.                                   | —                                          |
| December 2007,<br>version 1.4 | ■ Added “Referenced Documents” section.<br>■ Updated Figure 6–1. | Updated document with MAX IIZ information. |
| December 2006,<br>version 1.3 | ■ Added document revision history.                               | —                                          |
| October 2006,<br>version 1.2  | ■ Updated Figure 6-1.                                            | —                                          |
| June 2005,<br>version 1.1     | ■ Removed Dual Marking section.                                  | —                                          |